

HIGH-POWER NPN SILICON POWER TRANSISTORS

...designed for use in general-purpose amplifier and switching application .

FEATURES:

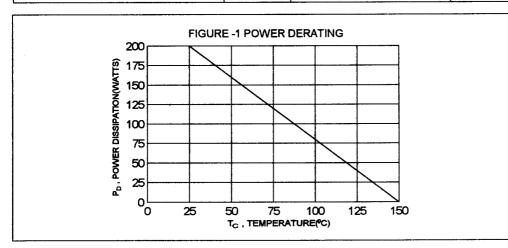
- * Recommend for 150W High Fiderity Audio Frequency Amplifier Output stage
- * Complementary to 2SA1295

MAXIMUM RATINGS

Characteristic	Symbol	2SC3264	Unit
Collector-Emitter Voltage	V _{CEO}	230	V
Collector-Base Voltage	V _{CBO}	230	V
Emitter-Base Voltage	V _{EBO}	5.0	V
Collector Current - Continuous - Peak	I _C	17 20	А
Base current	l _B	5.0	A
Total Power Dissipation @ T _C = 25°C Derate above 25°C	P _D	200 1.6	W/°C
Operating and Storage Junction Temperature Range	T _J ,T _{STG}	-55 to +150	°C

THERMAL CHARACTERISTICS

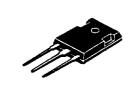
Characteristic	Symbol	Max	Unit
Thermal Resistance Junction to Case	Rθjc	0.625	°C/W



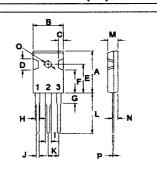
NPN 2SC3264

17 AMPERE POWER TRANASISTOR

230 VOLTS 200 WATTS



TO-247(3P)



PIN 1.BASE 2.COLLECTOR 3.EMITTER

DIM	MILLIMETERS			
Dilvi	MIN	MAX		
Α	20.63	22.38		
В	15.38	16.20		
С	1.90	2.70		
D	5.10	6.10		
E	14.81	15.22		
F	11.72	12.84		
G	4.20	4.50		
н	1.82	2.46		
1	2.92	3.23		
J	0.89	1.53		
K	5.26	5.66		
L	18.50	21.50		
M	4.68	5.36		
N ·	2.40	2.80		
0	3.25	3.65		
P	0.55	0.70		

us

Characteri	stic	Symbol	Min	Max	Unit
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltag (I _C = 25 mA, I _B = 0)	e	V _{(BR)CEO}	230		V
Collector Cutoff Current (V _{CB} = 230 V, I _E = 0)		Ісво		100	uA
Emitter Cutoff Current (V _{EB} = 5.0 V, I _C = 0)		 EBO		100	uА
ON CHARACTERISTICS (1)					
DC Current Gain (I _C = 5.0 A, V _{CE} = 4.0 V)		hFE	40		
Collector-Emitter Saturation Voltage (I_c = 5.0 A, I_B = 500 mA)		V _{CE(sat)}		2.0	V
DYNAMIC CHARACTERISTICS					
Current-Gain-Bandwidth Product (I _C = 2.0 A, V _{CE} = 12 V, f = 1.0 MHz	2)	f _T	10		MHz
SWTCHING CHARATERISTICS			•		
	V _{CC} = 60 V, I _C = 5.0 A I _{B1} = -I _{B2} = 500 mA R _L = 12 ohm	t on	0.30(typ)		us
		t s	2.40(typ)		us
Fall Time		+	0.50(typ)		116

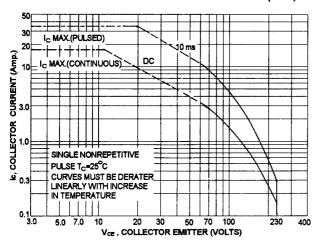
0.50(typ)

tf

Fall Time

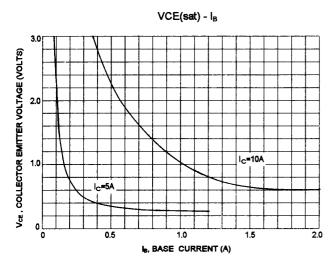
⁽¹⁾ Pulse Test: Pulse Width =300 us, Duty Cycle ≤ 2.0%

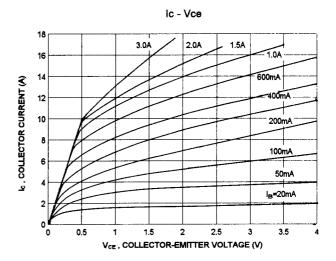
ACTIVE-REGION SAFE OPERATING AREA (SOA)

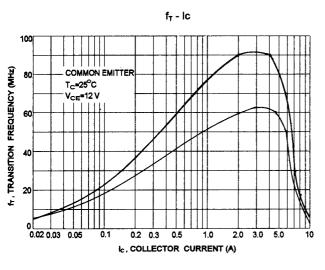


There are two limitation on the power handling ability of a transistor:average junction temperature and second breakdown safe operating area curves indicate $\rm I_{C^-}V_{CE}$ limits of the transistor that must be observed for reliable operation i.e., the transistor must not be subjected to greater dissipation than curves indicate.

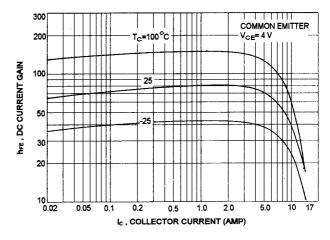
The data of SOA curve is base on $T_{J(PK)}$ =150 °C; T_C is variable depending on conditions, second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(PK)}$ ≤150°C,At high case temperatures, thermal limitation will reduce the power that can be handled to values less than the limitations imposed by second breakdown.













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